

**Search Notes**

Application/Control No.

10/649,667

Examiner

Edward Wojciechowicz

Applicant(s)/Patent under  
Reexamination

ARAO ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	59	3-5-05	EDJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR